

09/936487

JC03 Rec'd PCT/PTO 10 SEP 2001
Atty. Docket No.: 15675.03
Express Mail #: EL651820244US

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re the application of:

Dominique Barthel

For: METHOD FOR TESTING INTEGRATED CIRCUITS
WITH MEMORY ELEMENT

PRELIMINARY AMENDMENT

Hon. Commissioner of
Patents and Trademarks
Washington, D.C. 20231

Dear Sir:

Prior to the examination of the above-identified application, Applicant requests entry of the following amendment:

IN THE SPECIFICATION

At page 4, please delete the specification beginning at line 23 and ending on page 5, line 30 through the words "boundary scan claim" and replace with the following: